



General Description

The WST3407 is the highest performance trench P-ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WST3407 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

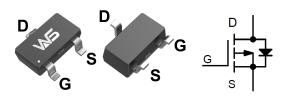
Product Summery

BVDSS	RDSON	ID
-30V	41mΩ	-5.8A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23-3L Pin Configuration



Rating Symbol **Parameter** Units **Steady State** 10s V_{DS} Drain-Source Voltage -30 V Gate-Source Voltage ±20 V V_{GS} Continuous Drain Current, V_{GS} @ -10V¹ -6.3 I_D@T_C=25℃ -5.8 А Continuous Drain Current, V_{GS} @ -10V¹ I_D@T_C=70℃ -4.5 -3.5 А Pulsed Drain Current² -20 А I_{DM} P_D@T_A=25℃ Total Power Dissipation³ 1.32 W 1 Total Power Dissipation³ 0.64 W P_D@T_A=70℃ 0.84 Storage Temperature Range -55 to 150 °C $\mathsf{T}_{\mathsf{STG}}$ **Operating Junction Temperature Range** -55 to 150 °C ТJ

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹		125	°C/W
R _{0JA}	Thermal Resistance Junction-Ambient 1 (t ≤10s)		95	°C /W
R _{θJC}	Thermal Resistance Junction-Case ¹		80	°C/W

Absolute Maximum Ratings



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I _D =-250uA	-30			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ\!\!{\rm C}$, I_D=-1mA		-0.023		V/℃
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-3A		41	52	mΩ
		V _{GS} =-4.5V , I _D =-2A		62	90	
V _{GS(th)}	Gate Threshold Voltage	—V _{GS} =V _{DS} , I _D =-250uA	-1.2	-1.8	-2.5	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			4		mV/℃
	Drain Source Lookage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C		-1		
I _{DSS}	Drain-Source Leakage Current	V_{DS} =-24V , V_{GS} =0V , T_{J} =55 $^{\circ}\mathrm{C}$			-5	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-3A		11		S
Qg	Total Gate Charge (-4.5V)	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-3A		6.4	9.0	
Q _{gs}	Gate-Source Charge			2.3	3.2	nC
Q _{gd}	Gate-Drain Charge			1.9	2.7	
T _{d(on)}	Turn-On Delay Time			2.8	5.6	
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_{G} =3.3 Ω ,		8.4	15.1	
T _{d(off)}	Turn-Off Delay Time	I _D =-3A		39	78.0	ns
	Fall Time			6	12.0	
C _{iss}	Input Capacitance			583	816	
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		100	140	pF
C _{rss}	Reverse Transfer Capacitance	<u> </u>		80	112	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,4}				-2	А
I _{SM}	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current			-20	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25℃			-1	V
trr	Reverse Recovery Time			11		nS
Q _{rr}	Reverse Recovery Charge	I⊧=-3A , dI/dt=100A/µs , Tյ=25℃		5.3		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

3.The power dissipation is limited by 150 $^\circ\!\!\mathbb{C}$ junction temperature

4. The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.



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Typical Characteristics

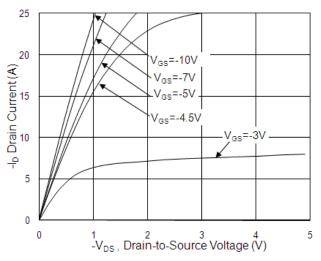


Fig.1 Typical Output Characteristics

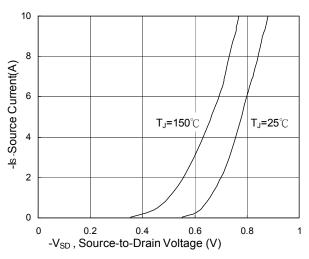


Fig.3 Forward Characteristics of Reverse

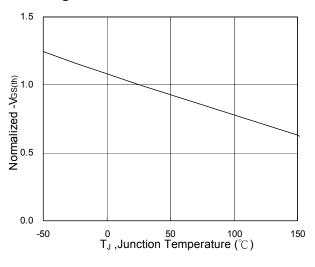


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

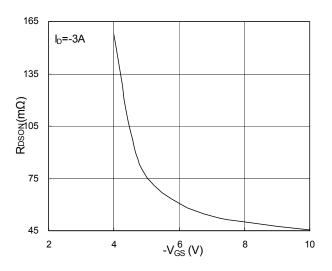


Fig.2 On-Resistance v.s Gate-Source

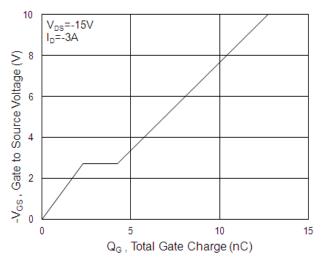


Fig.4 Gate-Charge Characteristics

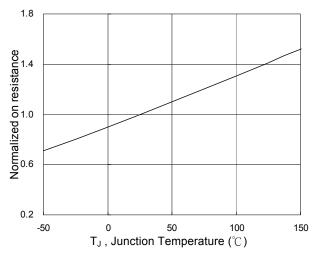
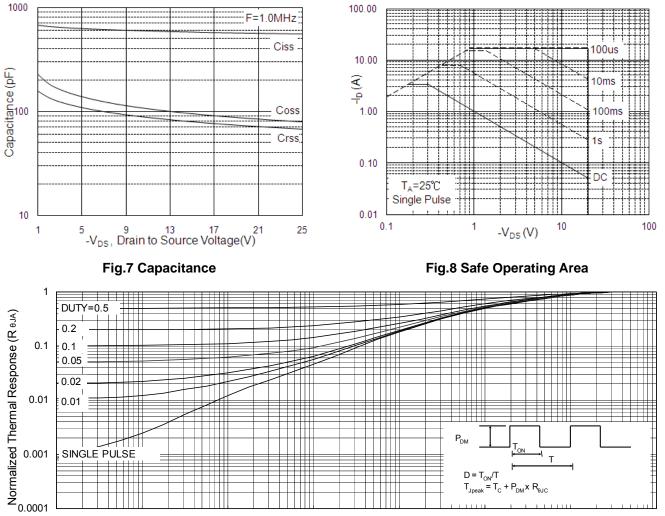


Fig.6 Normalized R_{DSON} vs T_{J}



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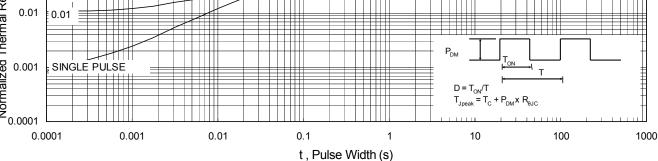
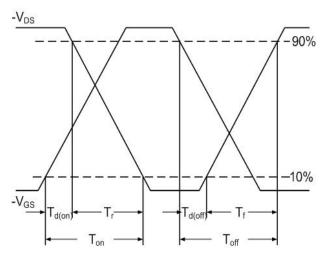


Fig.9 Normalized Maximum Transient Thermal Impedance





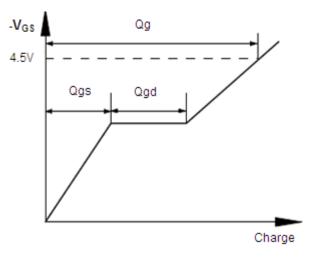


Fig.11 Gate Charge Waveform



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